

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/814,750	FUJIO ET AL.	
Examiner		Art Unit	Charlotte M. Baker	
		2625	Page 1 of 1	

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*	B	US-6,647,125	11-2003	Matsumoto et al.	382/100
*	C	US-2002/0141004	10-2002	Hayashi, Eiichi	358/519
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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